

Issue Classification				Application/Control No.		Applicant(s)/Patent under Reexamination	
				09/537,367		SAWANO, TAKASHI	
				Examiner:		Art Unit	
				CHAN S. PARK		2622	



ISSUE CLASSIFICATION

ORIGINAL				CROSS REFERENCE(S)								
CLASS		SUBCLASS		CLASS		SUBCLASS (ONE SUBCLASS PER BLOCK)						
358		1.15		358		1.16	1.17	404	437	444		
INTERNATIONAL CLASSIFICATION												
G	0	6	F	15/00								
H	0	4	N	1/00								
H	0	4	N	1/40								
			/									
			/									
CHAN S. PARK 10/21/05 (Assistant Examiner) (Date)				JOSEPH COLES SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2600 (Primary Examiner) (Date)				Total Claims Allowed: 38				
K. Davis 11/05 (Legal Instruments Examiner) (Date)								O.G. Print Claim(s)		O.G. Print Fig.		
								1		6 & 8		

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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5	9	31	39	69	99	129	159
6	10	32	40	70	100	130	160
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